

Search Notes

Application/Control No.

09/893,890

Examiner

David Q. Nguyen

Applicant(s)/Patent under
Reexamination

SALO ET AL.

Art Unit

2617

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR